Viacarbon

Carbon Nanotubes for Interconnects and Switches

John Robertson

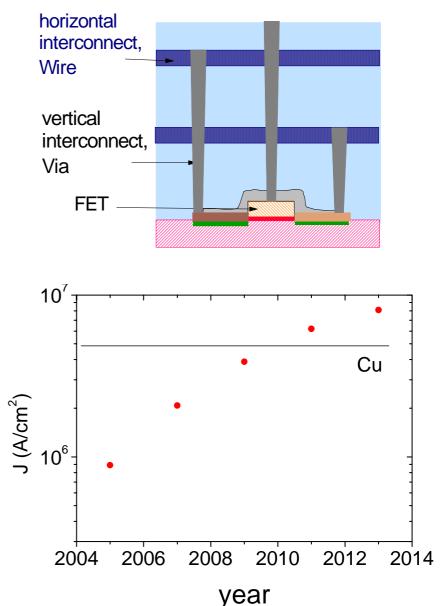
Cambridge University

Partners

- 1 Cambridge University, Dept. Engineering (Robertson)
- 2 CEA (Grenoble) Leti, Liten (M Scannell..)
- 3 Ecole Polytechnique Federale Lausanne (Adrian Ionescu)
- 4 Intel (Ireland) (Jenny Patterson)

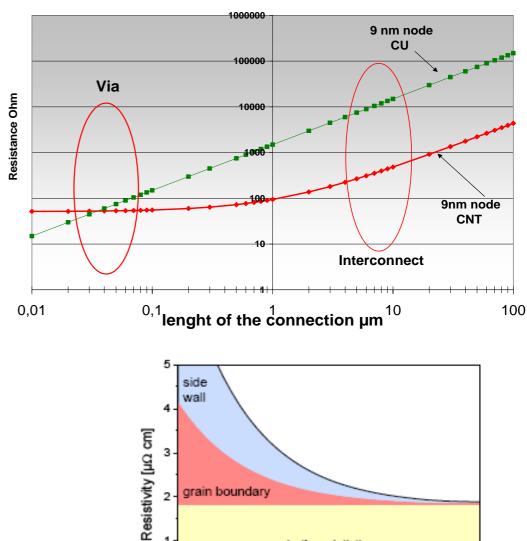
Background

- ITRS roadmap needs interconnects with J > 5.10⁶ A/cm² beyond 22 nm node
- beyond limit of Cu
- Carbon nanotubes are only material to carry J = 10⁹ A/cm² without failure by electromigration
- 'There is no (electrical) alternative'
- But, practical implementation of CNT interconnects is quite uncertain, no technology



Requirement

- CNTs = 1D conductors, limited by quantum of conductance, $G_0 =$ $4h/e^2/channel \rightarrow R = 6.5K\Omega$
- G₀ acts as series resistance
- Difficult to get R below Cu for vertical Vias, but easier for horizontal Wires
- Need very high density of CNT channels in parallel
- Need single-walled nanotubes
- densities over 10¹³ cm⁻²
- 3 nm spacing



0+

bulk resistivity

100

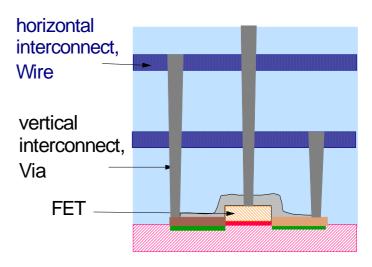
Linewidth (nm)

1000

Objectives

- Develop an industry-compatible process for vertical interconnects
- Develop an industry-compatible process for horizontal interconnects
- Optimize growth catalyst and process conditions for SWNT density ~10¹³ cm⁻²
- Low resistivity contacts, total R < 50 Ω
- Fabricate MNWT-based NEMS capacitive switch,

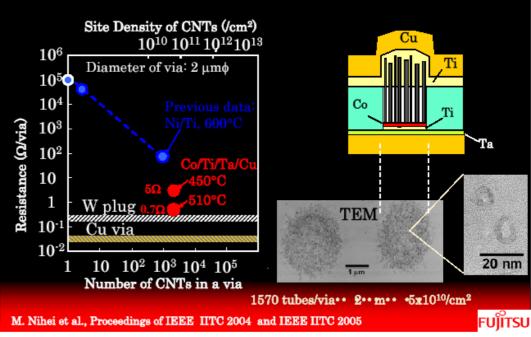
- C_{on}/C_{off} >100 for 2-5 GHz



Previous work, Vias

- Leading work in Europe in 2003 was by Infineon
- Leading work presently Fujitsu
- They have reached n=10¹¹ cm⁻²

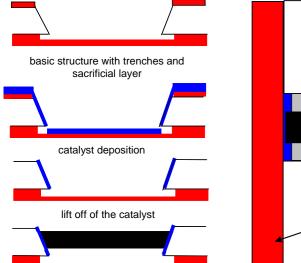
 In addition, many technical problems

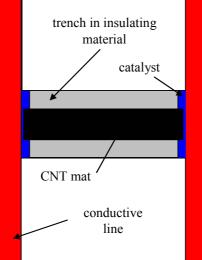


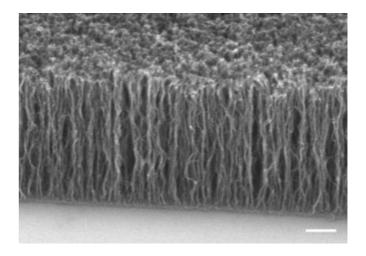
Resistance of CNT Vias

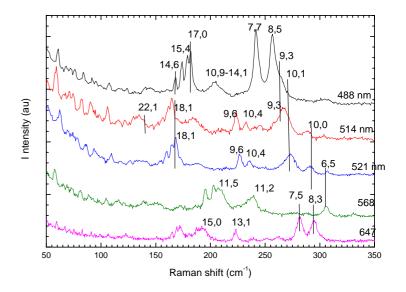
Technology

- High density nucleation for Vias – catalyst design
- Catalyst deposition (cluster dep)
- Characterisation (TEM, Raman)
- Top contacts
- Side-wall catalysts for Wires
- Coated trenches









CNT Mat growth

NEMs

- Nanotubes have very high stiffness, low density, and large current carrying capacity
- In principle, good NEMs material
- Horizontal RF NEMs switch
- Based of growth techniques developed for Wires

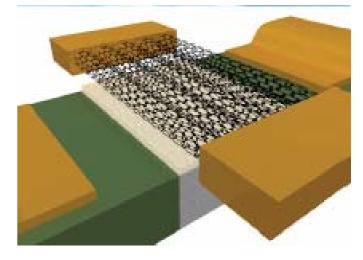
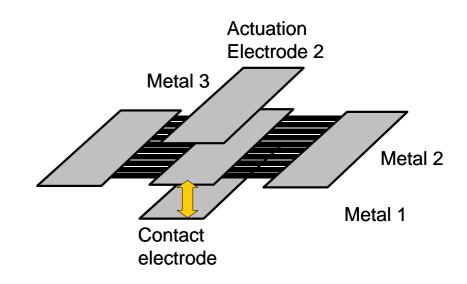


Fig. 3. Schematic of a NEMS relay.



Expertise of partners

- Ucam nanotube growth, catalyst design, characterisation
- CEA nanotubes, processing, integration
- EPFL NEMs, modelling, nanotubes
- Intel processing, integration, end-user

Work packages

WP	title
1	Growth optimisation
2	Vertical interconnect technology
3	Horizontal interconnect technology
4	RF NEMs

